

MOSFET - N-Channel, POWERTRENCH®

60 V, 100 A, 3 Ω

FDMS030N06B

Description

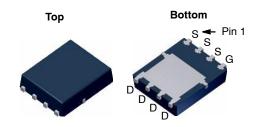
This N-Channel MOSFET is produced using **onsemi**'s advance POWERTRENCH process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Features

- $R_{DS(on)} = 2.4 \text{ m (Typ)}$ at $V_{GS} = 10 \text{ V}$, $I_D = 50 \text{ A}$
- Advanced Package and Silicon Combination for Low R_{DS(on)} and High Efficiency
- Fast Switching Speed
- 100% UIL Tested
- RoHS Compliant

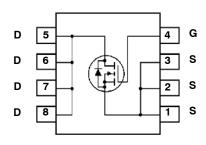
Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies
- Renewable system



PQFN8 5 × 6, 1.27P (Power 56) CASE 483AE

PIN CONNECTIONS



MARKING DIAGRAM

&Z&3&K FDMS 030N06B

&Z = Assembly Plant Code &3 = 3-Digit Date Code

&K = 2-Digit Lot Run Traceability Code

FDMS030N06B = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMS030N06B	PQFN8	3000 /
	(Pb-Free,	Tape & Reel
	Halide Free)	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter			FDMS030N06B	Unit
V _{DSS}	Drain to Source Voltage			60	V
V_{GSS}	Gate to Source Voltage			±20	V
I _D	Drain Current	Continuous (Note 1)	T _C = 25°C	100	Α
		Continuous (Note 2a)	T _A = 25°C	22.1	
I _{DM}	Drain Current	Pulsed (Note 3)		400	
E _{AS}	Single Pulse Avalanche Energy	(Note 4)		248	mJ
P_{D}	Power Dissipation T _C = 25°C		T _C = 25°C	104	W
			T _A = 25°C (Note 2a)	2.5	
T _J , T _{STG}	Operating and Storage Junction	Temperature Range	•	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	FDMS030N06B	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max (Note 2a)	50	

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

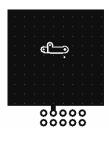
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	60	-	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	_	0.03	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	-	1	μΑ
I _{GSS}	Gate to Body Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±100	nA
ON CHARA	ACTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	2.5	3.3	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 50 A	-	2.4	3.0	mΩ
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 50 A	-	119	-	S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz	_	5685	7560	pF
C _{oss}	Output Capacitance		_	1720	2290	pF
C _{rss}	Reverse Transfer Capacitance		-	59	-	pF
C _{oss} (er)	Engry Releted Output Capacitance	V _{DS} = 30 V, V _{GS} = 0 V	-	2504	-	pF
Q _{g(tot)}	Total Gate Charge at 10 V	$V_{DS} = 30 \text{ V}, I_D = 50 \text{ A V}_{GS} = 0 \text{ V to } 10 \text{ V}$	-	75	-	nC
Q _{gs}	Gate to Source Gate Charge	(Note 5)	_	30	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		_	14	-	nC
V _{plateau}	Gate Plateau Voltage		_	5.4	-	V
Q _{sync}	Total Gate Charge Sync	V _{DS} = 0 V, I _D = 50 A	-	66.2		nC
Q _{oss}	Output Charge	V _{DS} = 30 V, V _{GS} = 0 V	-	174	_	nC
ESR	Equivalent Series Resistance	f = 1 MHz	_	1.05	-	Ω

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
WITCHIN	IG CHARACTERISTICS	•	•	•	•	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 50 \text{ A}, V_{GS} = 10 \text{ V},$	-	39	88	ns
t _r	Turn-On Rise Time	$R_{GEN} = 4.7 \Omega \text{ (Note 5)}$	-	20	50	ns
t _{d(off)}	Turn-Off Delay Time		-	52	114	ns
t _f	Turn-Off Fall Time		-	16	42	ns
RAIN-SO	DURCE DIODE CHARACTERISTICS					
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	100	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	400	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 50 A	-	-	1.25	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 50 A, dI _F /dt = 100 A/μs	-	71	-	ns
Q _{rr}	Reverse Recovery Charge		_	85	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. Silicon limited I_D rating = 147 A.
- 2. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper.

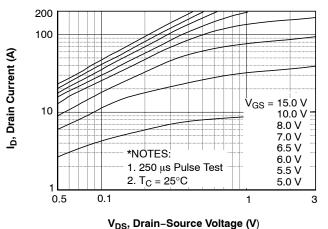


b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 3. Repetitive rating: pulse-width limited by maximum junction temperature.
- 4. L = 0.3 mH, I_{AS} = 40 A, V_{DD} = 50 V, V_{GS} = 10 V, starting T_J = 25°C. 5. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

ID, Drain Current (A)



VDS, Drain-Source voltage (V)

Figure 1. On-Region Characteristics

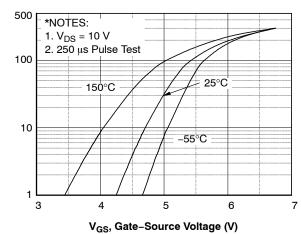


Figure 2. Transfer Characteristics

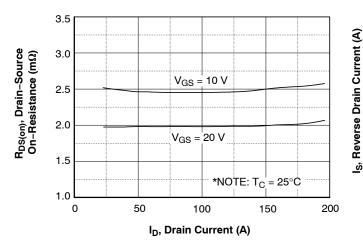


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

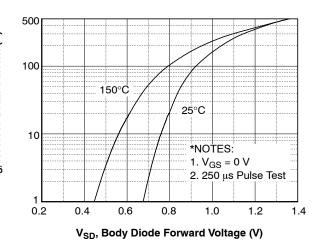


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

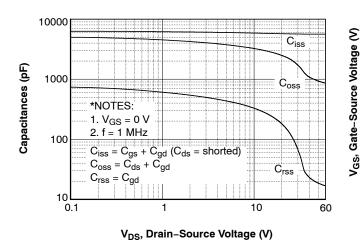


Figure 5. Capacitance Characteristics

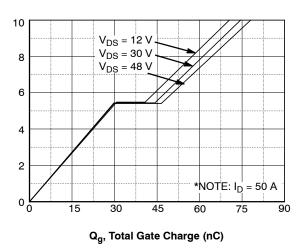


Figure 6. Gate Charge Characteristics

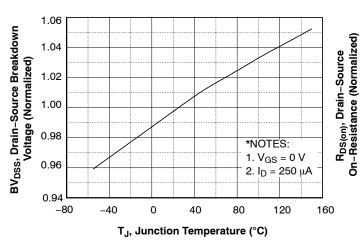
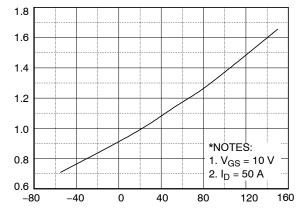


Figure 7. Breakdown Voltage Variation vs. Temperature



T_J, Junction Temperature (°C)
Figure 8. On-Resistance Variation vs.
Temperature

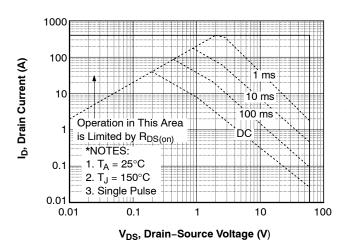


Figure 9. Maximum Safe Operating Area

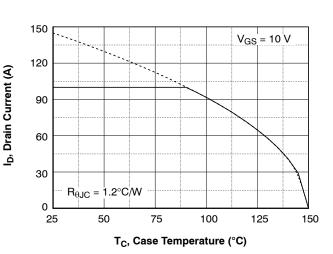


Figure 10. Maximum Drain Current vs. Case Temperature

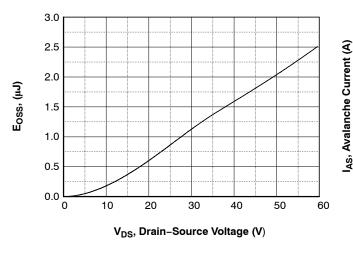


Figure 11. Eoss vs. Drain to Source Voltage

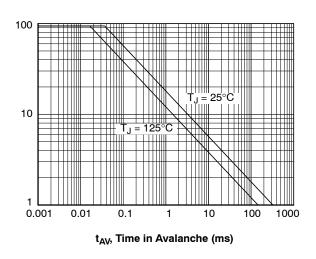


Figure 12. Unclamped Inductive Switching Capability

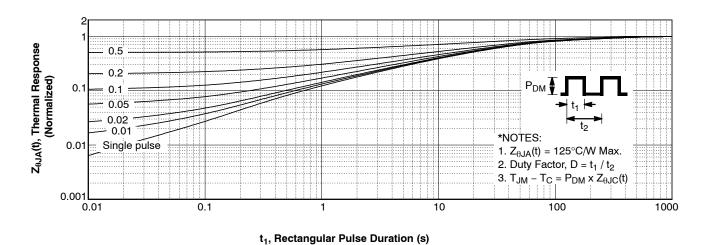


Figure 13. Transient Thermal Response Curve

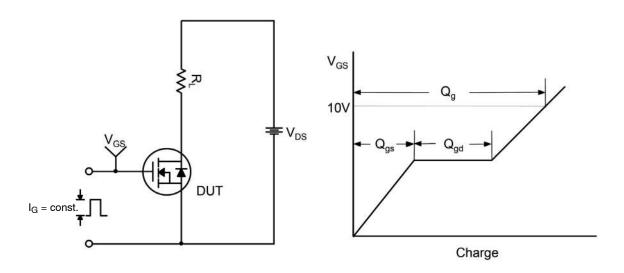


Figure 14. Gate Charge Test Circuit & Waveform

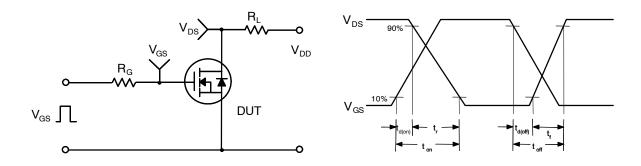


Figure 15. Resistive Switching Test Circuit & Waveforms

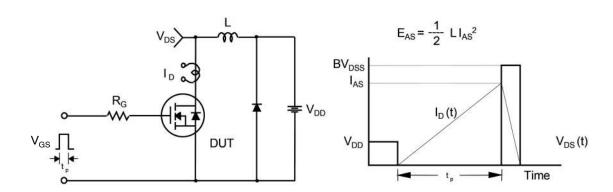


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

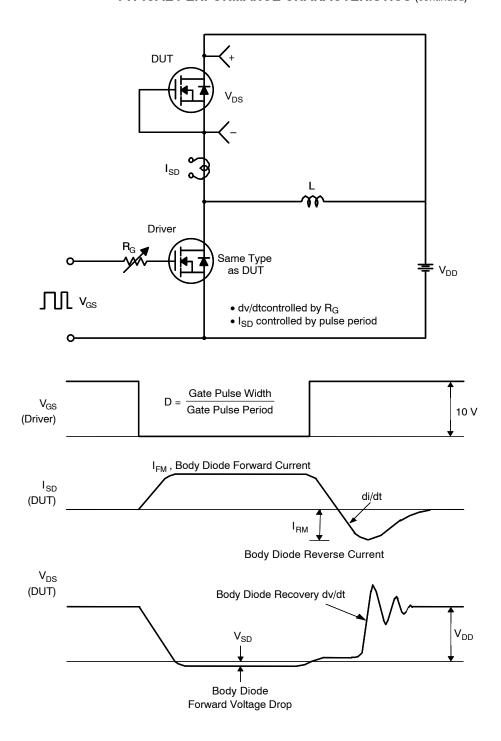


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

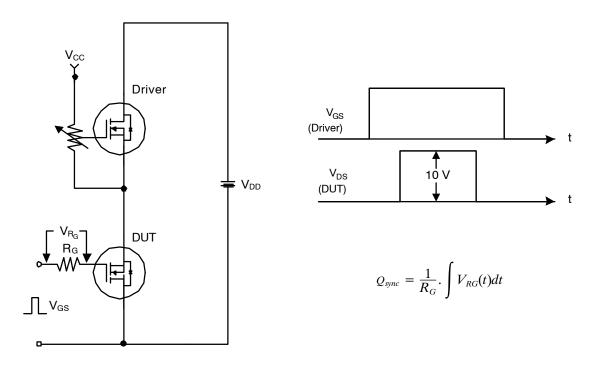
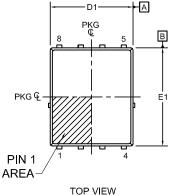


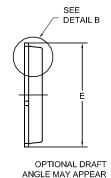
Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms





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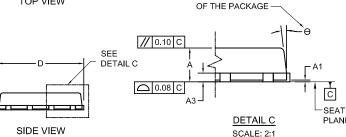


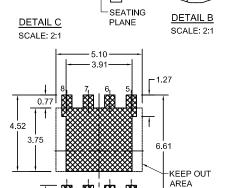


ON FOUR SIDES

NOTES:

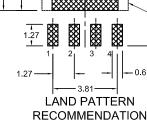
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.





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*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS				
Diivi	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.21	0.31	0.41		
b1	0.31	0.41	0.51		
А3	0.15	0.25	0.35		
D	4.90	5.00	5.20		
D1	4.80	4.90	5.00		
D2	3.61	3.82	3.96		
E	5.90	6.15	6.25		
E1	5.70	5.80	5.90		
E2	3.38	3.48	3.78		
E3	0.30 REF				
E4	0.52 REF				
е	1.27 BSC				
e/2	(0.635 BS	С		
e1	,	3.81 BSC	;		
e2	().50 REF			
L	0.51	0.66	0.76		
L2	0.05	0.18	0.30		
L4	0.34	0.44	0.54		
z	0.34 REF				
θ	0° - 12°				

(z) (4X) — — — — — — — — — — — — — — — — — — —	
(E3) (E3) (2X) b (8X) D2	
BOTTOM VIEW	

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DESCRIPTION:	PQFN8 5X6, 1.27P		PAGE 1 OF 1

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